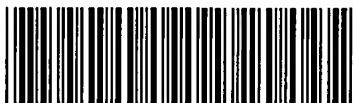


**Search Notes**

Application/Control No.

10/629,152

Examiner

Steven S. Paik

Applicant(s)/Patent under  
Reexamination

WU ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		
Text search		
235/492;487;451;380;382 340/828;825 705/26	10/26/2005	SSP